



### **60V N-CHANNEL ENHANCEMENT MODE MOSFET POWERDI**

## **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>C</sub> = +25°C
2014	10mΩ @ V <sub>GS</sub> = 10V	34A
60V	11.7mΩ @ V <sub>GS</sub> = 4.5V	31.5A

## **Description**

This MOSFET is designed to minimize the on-state resistance (RDS(ON)), yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

### **Applications**

- Backlighting
- Power Management Functions
- **DC-DC Converters**

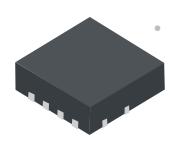
### **Features and Benefits**

- Low R<sub>DS(ON)</sub> Ensures On-State Losses Are Minimized
- Excellent Q<sub>gd</sub> x R<sub>DS(ON)</sub> Product (FOM)
- Advanced Technology for DC-DC Converters
- Small Form Factor Thermally Efficient Package Enables Higher **Density End Products**
- 100% UIS (Avalanche) Rated
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

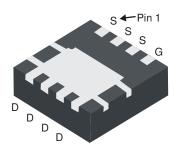
### **Mechanical Data**

- Case: POWERDI®3333-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.008 grams (Approximate)

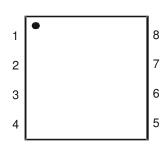
#### POWERDI3333-8



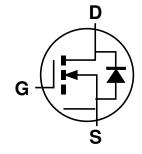
Top View



**Bottom View** 



Top View Internal Schematic



**Equivalent Circuit** 

## **Ordering Information** (Note 4)

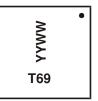
Part Number	Case	Packaging
DMT6009LFG-7	POWERDI3333-8	2,000/Tape & Reel
DMT6009LFG-13	POWERDI3333-8	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.</p>
  4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.



# **Marking Information**



T69 = Product Type Marking Code YYWW = Date Code Marking YY = Last Digit of Year (ex: 15 = 2015) WW = Week Code (01 to 53)

# **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage	V <sub>DSS</sub>	60	V	
Gate-Source Voltage	V <sub>GSS</sub>	±16	V	
Continuous Drain Current (Note 5) V <sub>GS</sub> = 10V	$T_C = +25^{\circ}C$ $T_C = +70^{\circ}C$	I <sub>D</sub>	34 27	А
Continuous Drain Current (Note 5) $V_{GS} = 10V$ $ T_A = +25^{\circ}C $ $ T_A = +70^{\circ}C $		I <sub>D</sub>	11 9	А
Maximum Continuous Body Diode Forward Current (Note 5)	Is	2.4	Α	
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I <sub>DM</sub>	90	Α	
Avalanche Current, L=0.1mH	I <sub>AS</sub>	28.6	Α	
Avalanche Energy, L=0.1mH	E <sub>AS</sub>	40.8	mJ	

## **Thermal Characteristics**

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$	$P_{D}$	2.08	W
Thermal Resistance, Junction to Ambient (Note 5)		$R_{\theta JA}$	60	°C/W
Total Power Dissipation (Note 5) $T_C = +25^{\circ}C$		$P_{D}$	19.2	W
Thermal Resistance, Junction to Case (Note 5)		Rejc	6.5	°C/W
Operating and Storage Temperature Range		$T_{J_i} T_{STG}$	-55 to +150	°C

Note: 5. ReJA is determined with the device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate. ReJC is guaranteed by design while ReJA is determined by the user's board design.

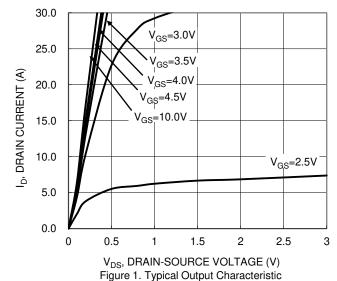


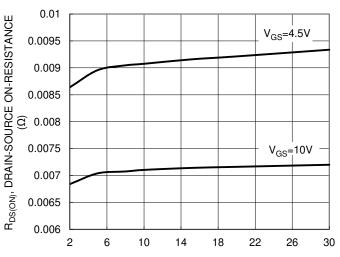
# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)					•		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	60	_	_	٧	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		_	1	μΑ	$V_{DS} = 48V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	0.7	_	2	٧	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance		-	_	10	mΩ	$V_{GS} = 10V, I_D = 13.5A$	
Static Drain-Source On-Nesistance	R <sub>DS(ON)</sub>	_	_	11.7	11122	$V_{GS} = 4.5V, I_D = 11.5A$	
Diode Forward Voltage	$V_{SD}$	_	_	1.2	V	$V_{GS} = 0V, I_S = 20A$	
DYNAMIC CHARACTERISTICS (Note 7)						•	
Input Capacitance	C <sub>iss</sub>	-	1,925	_		$V_{DS}$ = 30V, $V_{GS}$ = 0V, $f$ = 1MHz	
Output Capacitance	Coss	1	438	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	l	41				
Gate Resistance	$R_{g}$	1	1.7	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	15.6	_	-		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	33.5	_			
Gate-Source Charge	Q <sub>gs</sub>	_	4.7	_	nC	$V_{DS} = 30V, I_D = 13.5A$	
Gate-Drain Charge	Q <sub>qd</sub>	_	5.3	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	4.5	_			
Turn-On Rise Time	t <sub>R</sub>	_	8.6	_		$V_{DD} = 30V, V_{GS} = 10V,$ $R_G = 6\Omega, I_D = 13.5A$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	35.9	_	ns		
Turn-Off Fall Time	t <sub>F</sub>		15.7	_			
Body Diode Reverse Recovery Time	t <sub>RR</sub>	-	18.2	_	ns	1 40.54 4004/	
Body Diode Reverse Recovery Charge	Q <sub>RR</sub>		33.1	_	$_{\rm nC}$ $_{\rm l_F}$ = 13.5A, di/dt = 400A/µs		

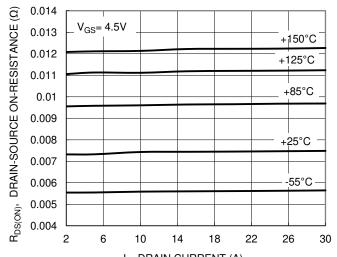
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing. Notes:



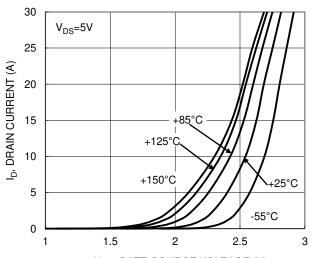




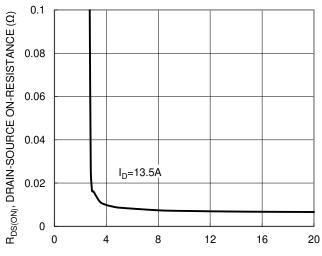
I<sub>D</sub>, DRAIN-SOURCE CURRENT (A) Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage



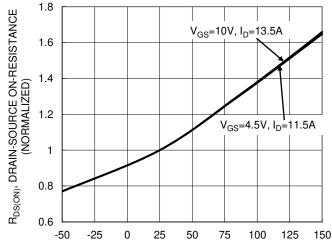
I<sub>D</sub>, DRAIN CURRENT (A) Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature



 $\rm V_{GS}$ , GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic



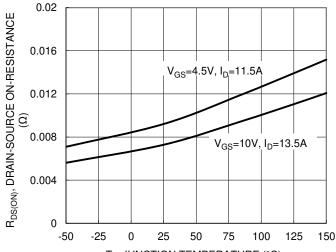
V<sub>GS</sub>, GATE-SOURCE VOLTAGE (V) Figure 4. Typical Transfer Characteristic



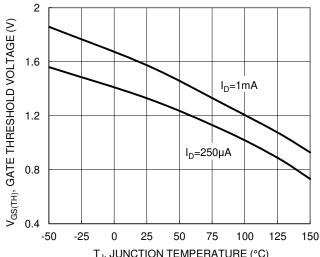
T<sub>J</sub>, JUNCTION TEMPERATURE (°C) Figure 6. On-Resistance Variation with Junction Temperature



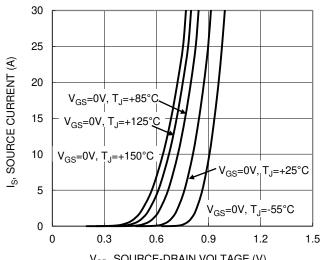




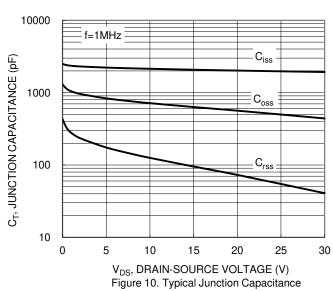
 $\rm T_{J},\,JUNCTION\,TEMPERATURE\,(^{\circ}C)$  Figure 7. On-Resistance Variation with Junction Temperature



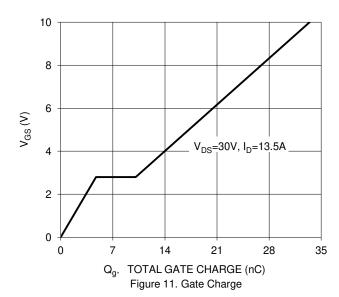
 $\mathsf{T_{J}},\mathsf{JUNCTION}$  TEMPERATURE (°C) Figure 8. Gate Threshold Variation vs. Junction Temperature



V<sub>SD</sub>, SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current



1000  $R_{DS(ON)}$  Limited 100 ID, DRAIN CURRENT (A) 10 P<sub>W</sub>=10ms ∰ P<sub>W</sub>=100ms 0.1  $T_{J(MAX)}$ =150°C  $T_A$ =25°C P<sub>W</sub>=10s 0.01 Single Pulse DUT on 1\*MRP board 0.001 0.01  $V_{DS}$ , DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area



100

10



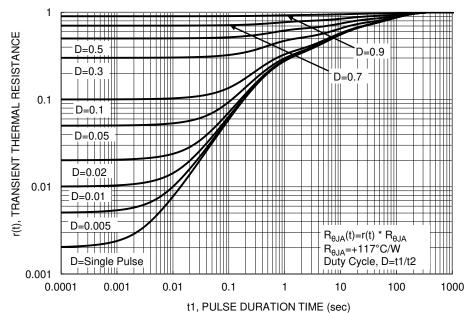


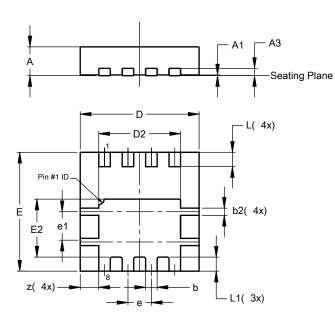
Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

### POWERDI3333-8

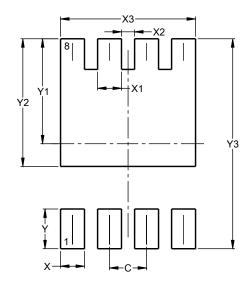


POWERDI3333-8						
Dim	Min	Max	Тур			
Α	0.75	0.85	0.80			
A1	0.00	0.05	0.02			
<b>A</b> 3	_	_	0.203			
b	0.27	0.37	0.32			
b2	_	_	0.20			
D	3.25	3.35	3.30			
D2	2.22	2.32	2.27			
E	3.25	3.35	3.30			
E2	1.56	1.66	1.61			
е	_	_	0.65			
e1	0.79	0.89	0.84			
L	0.35	0.45	0.40			
L1	_	_	0.39			
Z	_	_	0.515			
All Dimensions in mm						

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

### POWERDI3333-8



Dimensions	Value (in mm)		
С	0.650		
X	0.420		
X1	0.420		
X2	0.230		
Х3	2.370		
Υ	0.700		
Y1	1.850		
Y2	2.250		
V٦	3 700		



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